

Product Summary

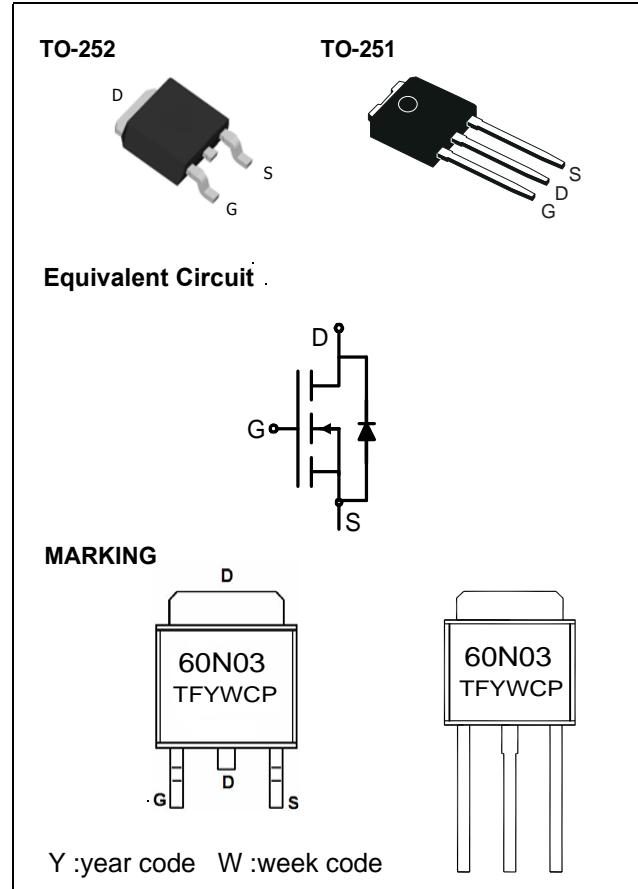
V_{DS}	30	V
$R_{DS(on),max}$ SMDversion	9	$m\Omega$
I_D	60	A

Features

- For fast switching converters and sync. rectification
- N-channel enhancement - normal level
- Avalanche rated
- Pb-free lead plating, RoHS compliant

Typical Applications

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits


Maximum ratings, at $T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_a = 25^\circ\text{C}$	60	A
Pulsed drain current	$I_{D,pulse}$	$t_p = 10\mu\text{s}$	120	
Avalanche energy, single pulse	E_{AS}	$I_D = 60\text{A}$ $R_{GS} = 25\Omega$	733	mJ
Gate source voltage	V_{GS}		± 20	V
Power dissipation	P_{tot}	$T_C = 25^\circ\text{C}$	75	W
Operating and storage temperature	T_j, T_{stg}		-55-150	°C
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T_L		260	°C
Thermal Resistance - Junction-to-Case - Junction-to-Ambient (Note 1) - Junction-to-Ambient (Note 2)	$R_{\theta JC}$ $R_{\theta JA}$ $R_{\theta JA}$		1.65 67 120	°C/W

1. When surface mounted to an FR4 board using 1" pad size, (Cu Area 1.127 in²).
2. When surface mounted to an FR4 board using the minimum recommended pad size, (Cu Area 0.412 in²).

*Chip current capability limited by package.

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage (Note 3) ($V_{GS} = 0 \text{ Vdc}$, $I_D = 250 \mu\text{Adc}$) Temperature Coefficient (Positive)	$V_{(BR)DSS}$	30		-	Vdc
Zero Gate Voltage Drain Current ($V_{GS} = 0 \text{ Vdc}$, $V_{DS} = 24 \text{ Vdc}$)	I_{DSS}	-	-	50	nAdc
Gate-Body Leakage Current ($V_{GS} = \pm 20 \text{ Vdc}$, $V_{DS} = 0 \text{ Vdc}$)	I_{GSS}	-	-	± 100	nAdc

ON CHARACTERISTICS (Note 3)

Gate Threshold Voltage (Note 3) ($V_{DS} = V_{GS}$, $I_D = 250 \mu\text{Adc}$) Threshold Temperature Coefficient (Negative)	$V_{GS(\text{th})}$	1.0	1.9	2.0	Vdc mV°C
Static Drain-to-Source On-Resistance (Note 3) ($V_{GS} = 10 \text{ Vdc}$, $I_D = 35 \text{ Adc}$) ($V_{GS} = 4.5 \text{ Vdc}$, $I_D = 20 \text{ Adc}$)	$R_{DS(\text{on})}$			9.0 15.0	$\text{m}\Omega$
Forward Transconductance ($V_{DS} = 15 \text{ Vdc}$, $I_D = 10 \text{ Adc}$) (Note 3)	g_{FS}	-	20	-	Mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	$(V_{DS} = 24 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C_{iss}	-	2150	-	pF
Output Capacitance		C_{oss}	-	680	-	
Transfer Capacitance		C_{rss}	-	260	-	

SWITCHING CHARACTERISTICS (Note 4)

Turn-On Delay Time	$(V_{DD} = 15 \text{ Vdc}, I_D = 15 \text{ Adc}, V_{GS} = 10 \text{ Vdc}, R_G = 3.3 \Omega)$	$t_{d(on)}$	-	10	-	ns
Rise Time		t_r	-	18	-	
Turn-Off Delay Time		$t_{d(off)}$	-	32	-	
Fall Time		t_f	-	15	-	
Gate Charge	$(V_{DS} = 24 \text{ Vdc}, I_D = 15 \text{ Adc}, V_{GS} = 4.5 \text{ Vdc})$ (Note 3)	Q_T	-	30	-	nC
		Q_1	-	6.5	-	
		Q_2	-	18.4	-	

SOURCE-DRAIN DIODE CHARACTERISTICS

Forward On-Voltage ($I_S = 2.3 \text{ Adc}$, $V_{GS} = 0 \text{ Vdc}$) (Note 3) ($I_S = 30 \text{ Adc}$, $V_{GS} = 0 \text{ Vdc}$) ($I_S = 2.3 \text{ Adc}$, $V_{GS} = 0 \text{ Vdc}$, $T_J = 150^\circ\text{C}$)	V_{SD}	-	0.75	1.0	Vdc
Reverse Recovery Time ($I_S = 2.3 \text{ Adc}$, $V_{GS} = 0 \text{ Vdc}$, $dI_S/dt = 100 \text{ A}/\mu\text{s}$) (Note 3)	t_{rr}	-	39	-	ns
	t_a	-	21	-	
	t_b	-	18	-	
Reverse Recovery Stored Charge	Q_{rr}	-	0.043	-	μC

3. Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2\%$.

4. Switching characteristics are independent of operating junction temperatures.

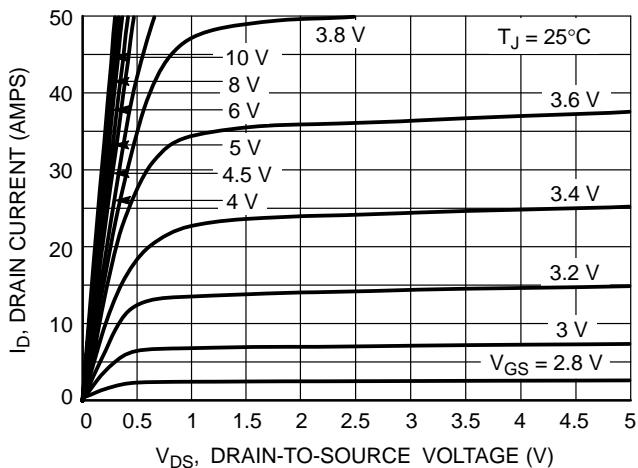


Figure 1. On-Region Characteristics

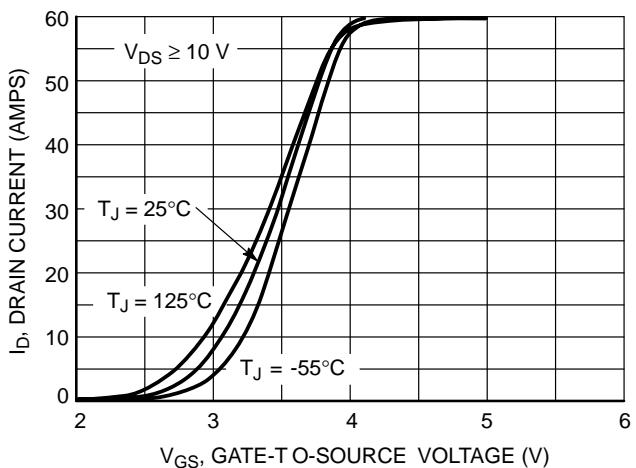


Figure 2. Transfer Characteristics

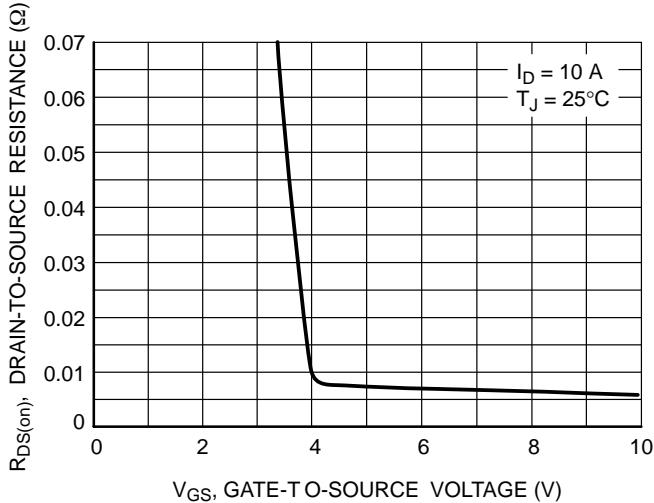


Figure 3. On-Resistance versus Gate-to-Source Voltage

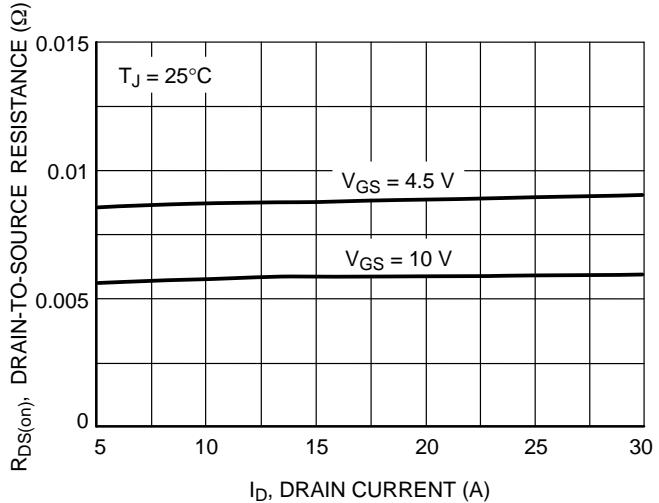


Figure 4. On-Resistance versus Drain Current and Gate Voltage

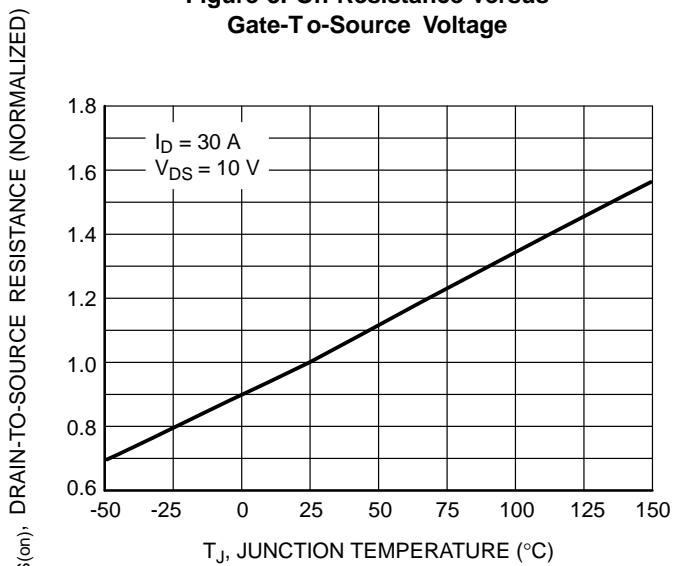


Figure 5. On-Resistance Variation with Temperature

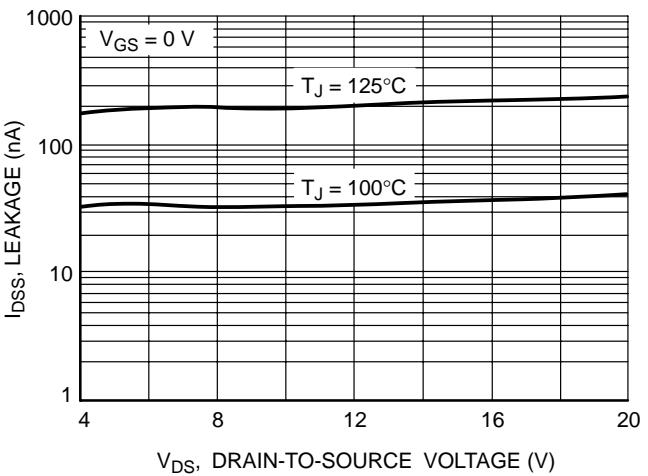


Figure 6. Drain-To-Source Leakage Current versus Voltage

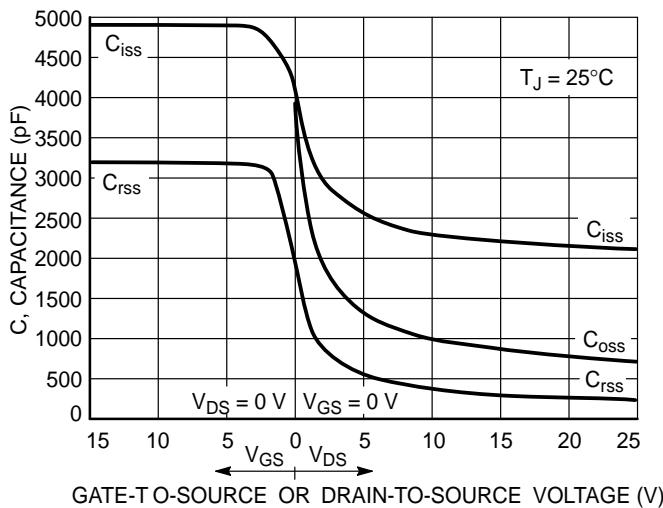


Figure 7. Capacitance Variation

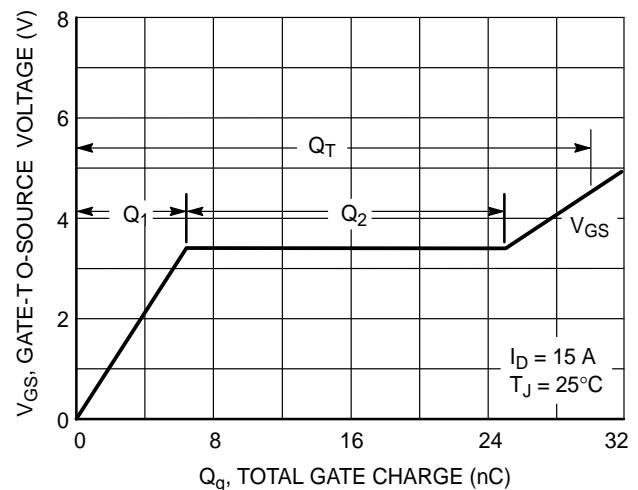


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

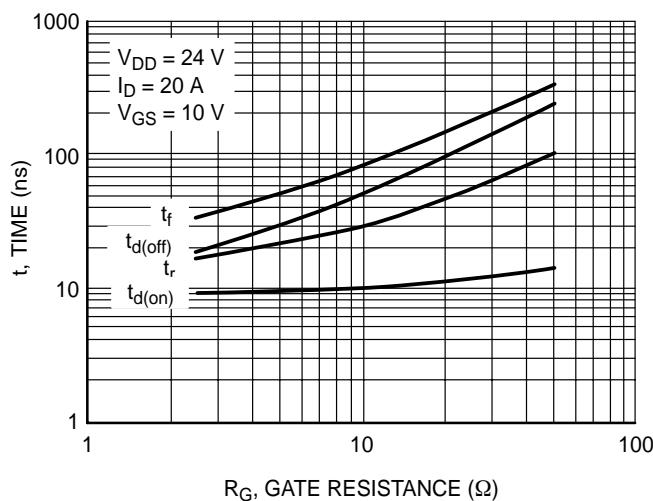


Figure 9. Resistive Switching Time Variation versus Gate Resistance

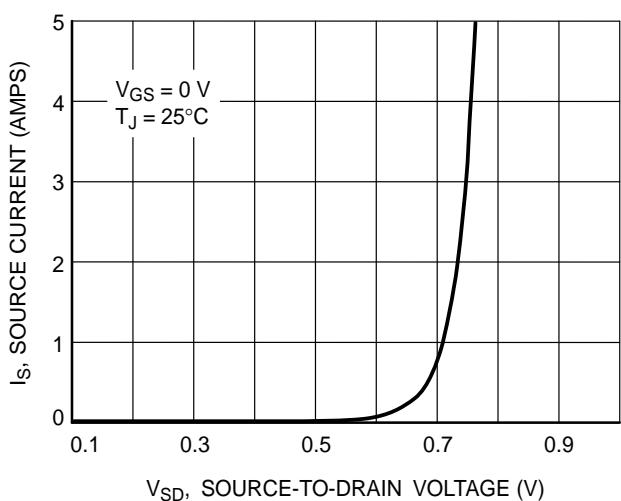


Figure 10. Diode Forward Voltage versus Current

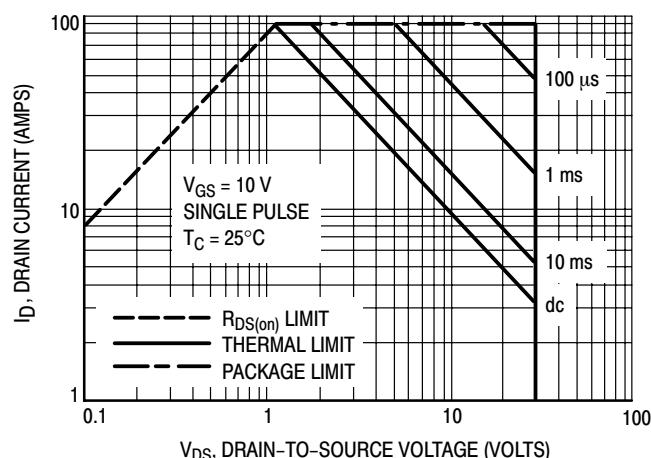


Figure 11. Maximum Rated Forward Biased Safe Operating Area

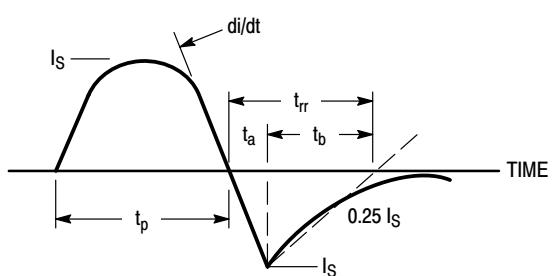


Figure 12. Diode Reverse Recovery Waveform

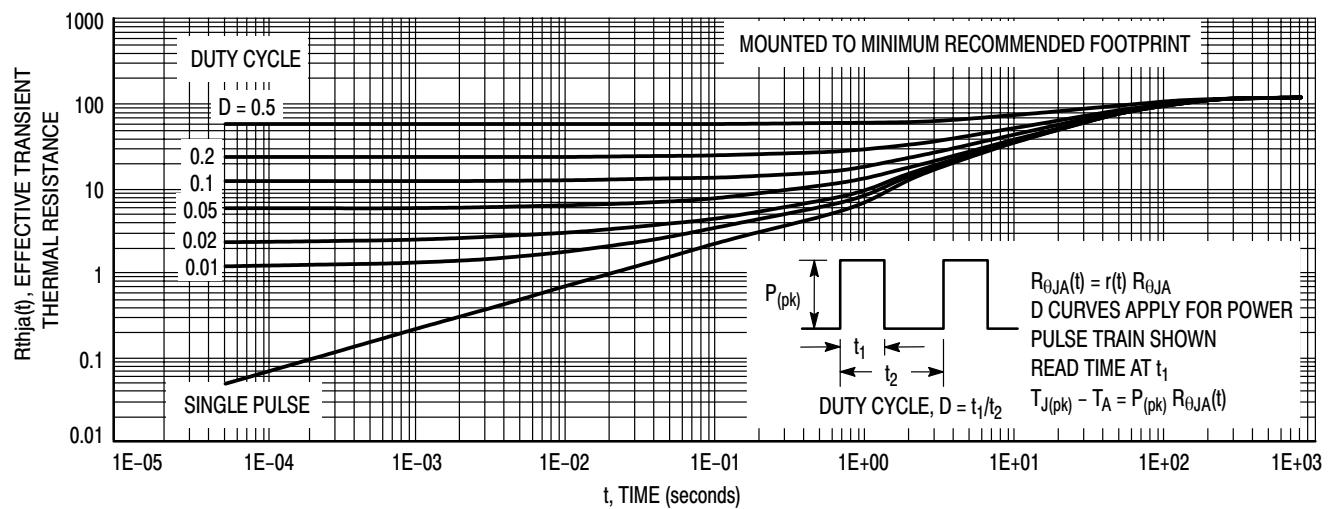
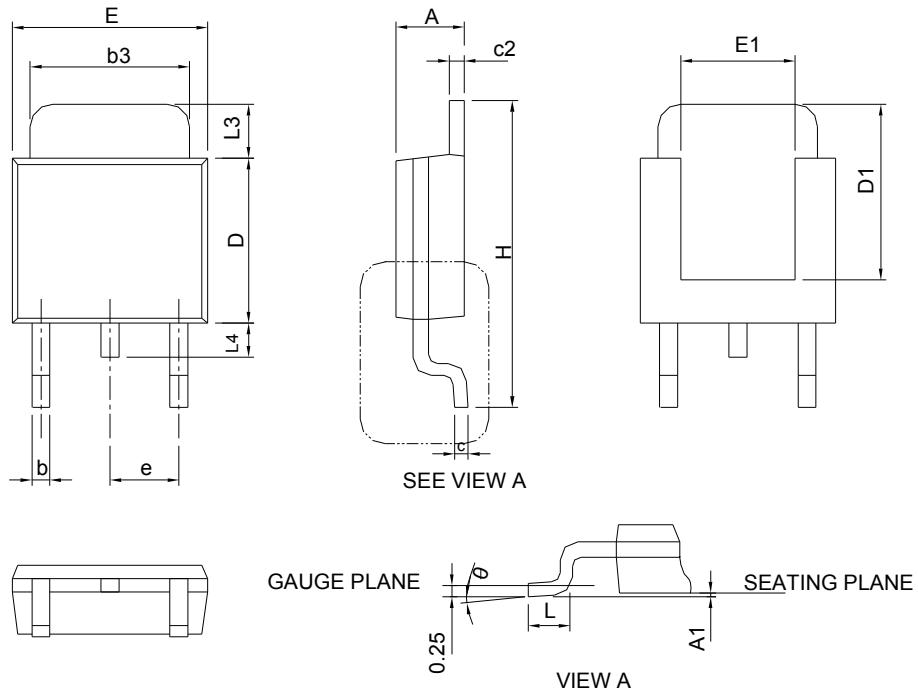


Figure 13. Thermal Response - Various Duty Cycles

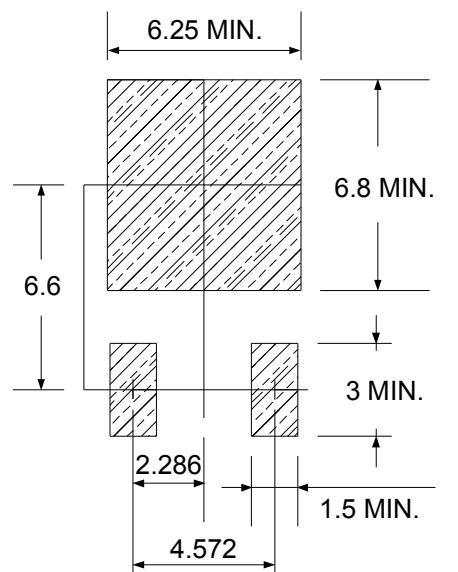
Package Information

TO-252



ITEM	TO-252			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	2.18	2.39	0.086	0.094
A1		0.13		0.005
b	0.50	0.89	0.020	0.035
b3	4.95	5.46	0.195	0.215
c	0.46	0.61	0.018	0.024
c2	0.46	0.89	0.018	0.035
D	5.33	6.22	0.210	0.245
D1	4.57	6.00	0.180	0.236
E	6.35	6.73	0.250	0.265
E1	3.81	6.00	0.150	0.236
e	2.29 BSC		0.090 BSC	
H	9.40	10.41	0.370	0.410
L	0.90	1.78	0.035	0.070
L3	0.89	2.03	0.035	0.080
L4		1.02		0.040
θ	0°	8°	0°	8°

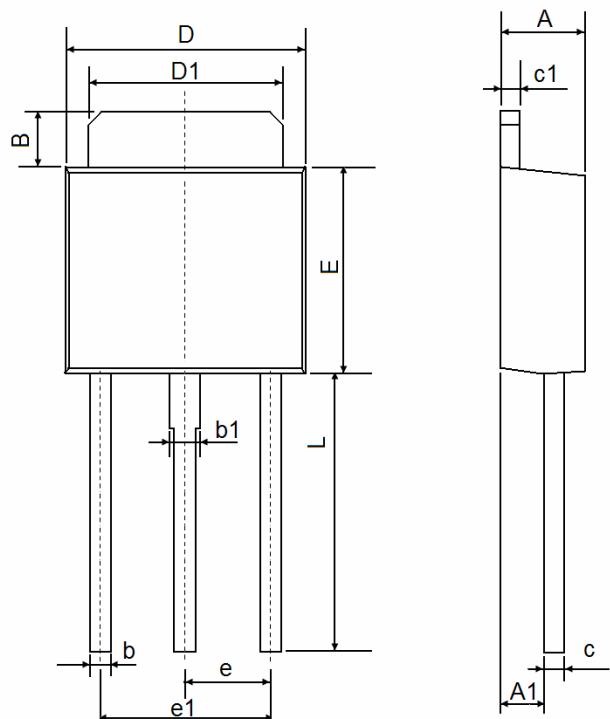
RECOMMENDED LAND PATTERN



UNIT: mm

Note : Follow JEDEC TO-252 .

TO-251 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	1.050	1.350	0.042	0.054
B	0.700	1.000	0.028	0.040
b	0.500	0.700	0.020	0.028
b1	0.700	0.900	0.028	0.035
c	0.430	0.580	0.017	0.023
c1	0.430	0.580	0.017	0.023
D	6.350	6.650	0.250	0.262
D1	5.200	5.400	0.205	0.213
E	5.400	6.000	0.213	0.237
e	2.300 TYP.		0.091 TYP.	
e1	4.500	4.700	0.177	0.185
L	4.900	9.400	0.194	0.372

Notes

- All dimensions are in millimeters.
- Tolerance $\pm 0.10\text{mm}$ (4 mil) unless otherwise specified
- Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- Dimension L is measured in gauge plane.
- Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.